

IR-Lumineszenzdiode (850 nm) mit hoher Ausgangsleistung
High Power Infrared Emitter (850 nm)
Lead (Pb) Free Product - RoHS Compliant
SFH 4235



Wesentliche Merkmale

- IR-Lichtquelle mit hohem Wirkungsgrad
- Niedriger Wärmewiderstand (Max. 9 K/W)
- Schwerpunktwellenlänge 850 nm
- ESD-sicher bis 2 kV nach JESD22-A114-E
- Erweiterte Korrosionsfestigkeit (s.a. Abschnitt Maßzeichnung)
- Die Produktqualifikation wurde basierend auf der Richtlinie AEC-Q101-REV-C, „Stress Test Qualification for Automotive Grade Discrete Semiconductors“, durchgeführt.

Anwendungen

- Infrarotbeleuchtung für Kameras
- Überwachungssysteme
- Beleuchtung für Bilderkennungssysteme

Sicherheitshinweise

Je nach Betriebsart emittieren diese Bauteile hochkonzentrierte, nicht sichtbare Infrarot-Strahlung, die gefährlich für das menschliche Auge sein kann. Produkte, die diese Bauteile enthalten, müssen gemäß den Sicherheitsrichtlinien der IEC-Normen 60825-1 und 62471 behandelt werden.

Features

- IR lightsource with high efficiency
- Low thermal resistance (Max. 9 K/W)
- Centroid wavelength 850 nm
- ESD safe up to 2 kV acc. to JESD22-A114-E
- Superior Corrosion Robustness (see chapter package outlines)
- The product qualification test plan is based on the guidelines of AEC-Q101-REV-C, Stress Test Qualification for Automotive Grade Discrete Semiconductors.

Applications

- Infrared Illumination for cameras
- Surveillance systems
- Machine vision systems

Safety Advices

Depending on the mode of operation, these devices emit highly concentrated non visible infrared light which can be hazardous to the human eye. Products which incorporate these devices have to follow the safety precautions given in IEC 60825-1 and IEC 62471.

Typ Type	Bestellnummer Ordering Code	Gesamtstrahlungsfluss ¹⁾ ($I_F = 1A, t_p = 10\text{ ms}$) Total Radiant Flux ¹⁾ Φ_e (mW)
SFH 4235	Q65110A8900	≥ 630 (typ. 950)

¹⁾ gemessen mit Ulbrichtkugel / measured with integrating sphere

Grenzwerte ($T_A = 25\text{ °C}$)**Maximum Ratings**

Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
Betriebs- und Lagertemperatur Operating and storage temperature range	T_{op}, T_{stg}	- 40 ... + 125	°C
Sperrschichttemperatur Junction temperature	T_J	+ 145	°C
Sperrspannung Reverse voltage	V_R	1	V
Vorwärtsgleichstrom Forward current	I_F	1	A
Stoßstrom, $t_p = 200\text{ }\mu\text{s}$, $D = 0$ Surge current	I_{FSM}	5	A
Leistungsaufnahme Power consumption	P_{tot}	3.4	W
Wärmewiderstand Sperrschicht - Lötstelle Thermal resistance junction - soldering point	R_{thJS}	9	K/W

Kennwerte ($T_A = 25\text{ °C}$)**Characteristics**

Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
Wellenlänge der Strahlung Wavelength at peak emission $I_F = 1\text{ A}$, $t_p = 10\text{ ms}$	λ_{peak}	860	nm
Schwerpunktwellenlänge der Strahlung Centroid wavelength $I_F = 1\text{ A}$, $t_p = 10\text{ ms}$	$\lambda_{centroid}$	850	nm
Spektrale Bandbreite bei 50% von I_{max} Spectral bandwidth at 50% of I_{max} $I_F = 1\text{ A}$, $t_p = 10\text{ ms}$	$\Delta\lambda$	30	nm
Abstrahlwinkel Half angle	φ	± 60	Grad deg.
Aktive Chipfläche Active chip area	A	1	mm ²
Abmessungen der aktiven Chipfläche Dimension of the active chip area	$L \times B$ $L \times W$	1×1	mm ²

Kennwerte ($T_A = 25\text{ °C}$)
Characteristics (cont'd)

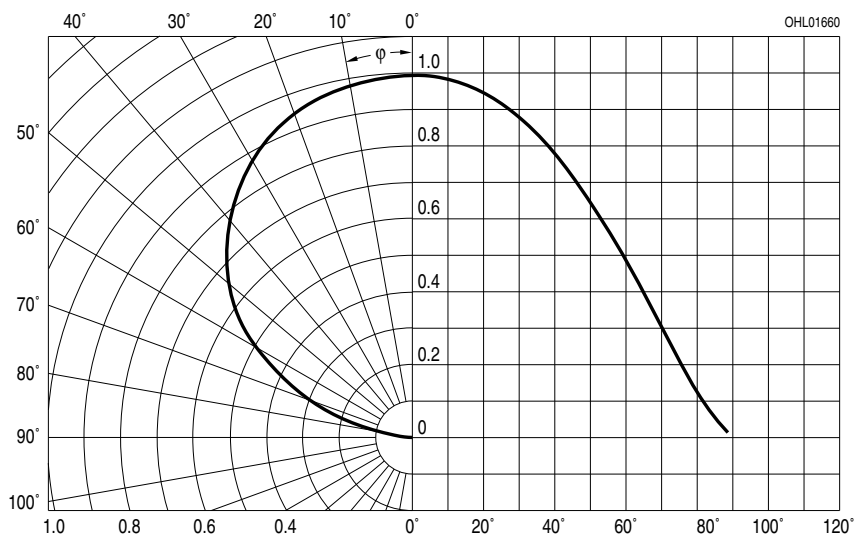
Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
Schaltzeiten, I_e von 10% auf 90% und von 90% auf 10%, $I_F = 5\text{ A}$, $R_L = 50\ \Omega$ Switching times, I_e from 10% to 90% and from 90% to 10%, $I_F = 5\text{ A}$, $R_L = 50\ \Omega$	t_r / t_f	7 / 14	ns
Durchlassspannung Forward voltage $I_F = 1\text{ A}$, $t_p = 100\ \mu\text{s}$ $I_F = 5\text{ A}$, $t_p = 100\ \mu\text{s}$	V_F V_F	3.0 (< 3.4) 3.5 (< 4.5)	V V
Strahlstärke Radiant intensity $I_F = 1\text{ A}$, $t_p = 100\ \mu\text{s}$	$I_{e\text{ typ}}$	320	mW/sr
Temperaturkoeffizient von I_e bzw. Φ_e Temperature coefficient of I_e or Φ_e $I_F = 1\text{ A}$, $t_p = 10\text{ ms}$	TC_I	- 0.3	%/K
Temperaturkoeffizient von V_F Temperature coefficient of V_F $I_F = 1\text{ A}$, $t_p = 10\text{ ms}$	TC_V	- 2	mV/K
Temperaturkoeffizient von λ Temperature coefficient of λ $I_F = 1\text{ A}$, $t_p = 10\text{ ms}$	$TC_{\lambda, \text{centroid}}$	+ 0.3	nm/K

Gesamtstrahlungsfluss¹⁾ Φ_e
Total Radiant Flux¹⁾ Φ_e

Bezeichnung Parameter	Symbol	Werte Values		Einheit Unit
		-EA	-EB	
Gesamtstrahlungsfluss Total Radiant Flux $I_F = 1 \text{ A}, t_p = 10 \text{ ms}$	$\Phi_{e \text{ min}}$ $\Phi_{e \text{ max}}$	630 1000	800 1250	mW mW

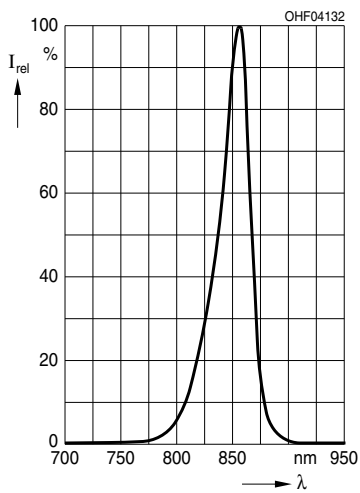
¹⁾ Nur eine Gruppe in einer Verpackungseinheit (Streuung kleiner 1.6:1) /
 Only one bin in one packing unit (variation lower 1.6:1)

Abstrahlcharakteristik
Radiation Characteristics $I_{\text{rel}} = f(\varphi)$



Relative spektrale Emission
Relative Spectral Emission

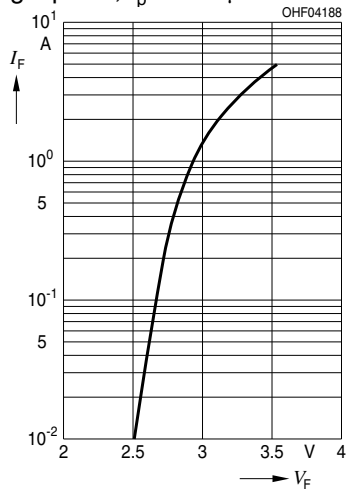
$I_{rel} = f(\lambda)$



Durchlassstrom
Forward Current

$I_F = f(V_F)$

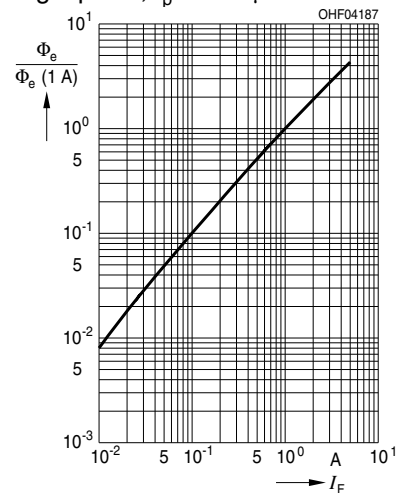
Single pulse, $t_p = 100 \mu s$



Relativer Gesamtstrahlungsfluss
Relative Total Radiant Flux

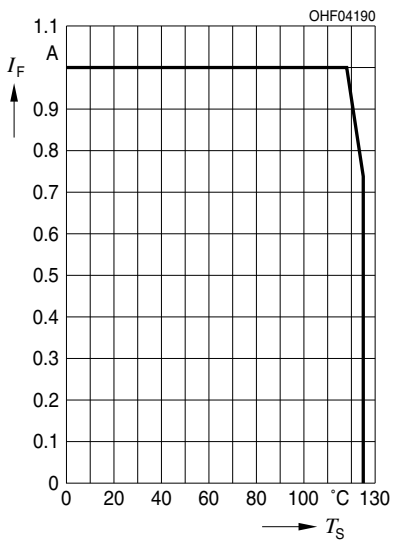
$\Phi_e / \Phi_e(1A) = f(I_F)$

Single pulse, $t_p = 100 \mu s$



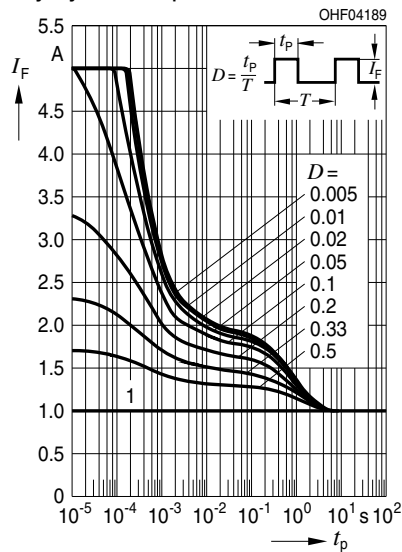
Max. zulässiger Durchlassstrom
Max. Permissible Forward Current

$I_F = f(T_A), R_{thJS} = 9 \text{ K/W}$

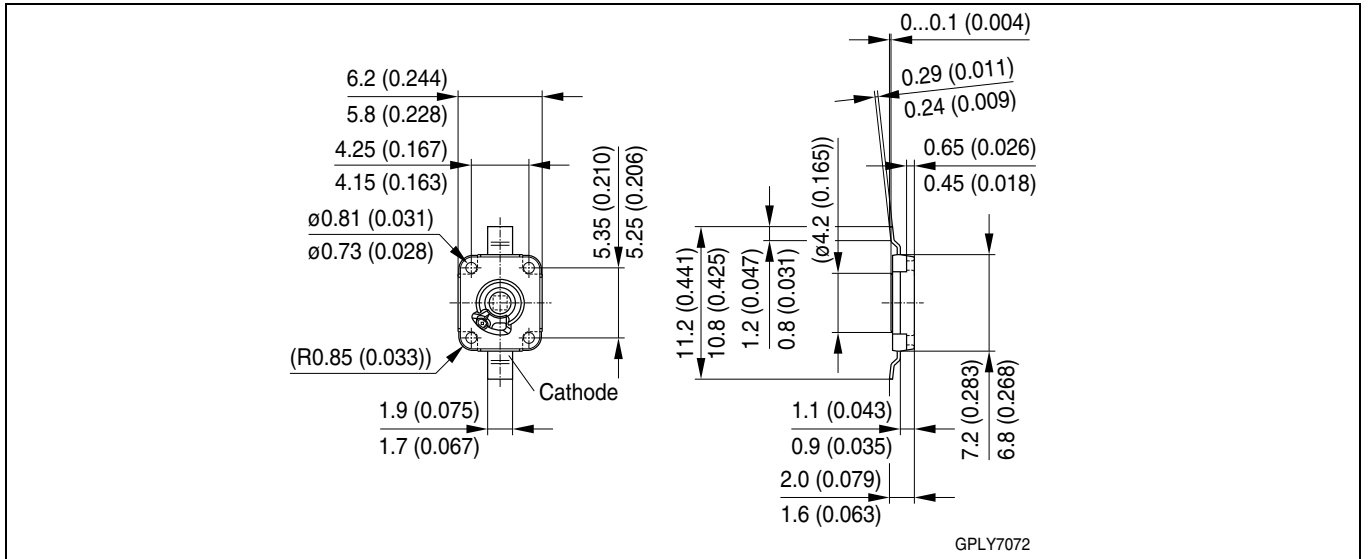


Zulässige Impulsbelastbarkeit
Permissible Pulse Handling

Capability $I_F = f(t_p), T_S = 85 \text{ °C}$,
Duty cycle $D =$ parameter



Maßzeichnung¹⁾
 Package Outlines



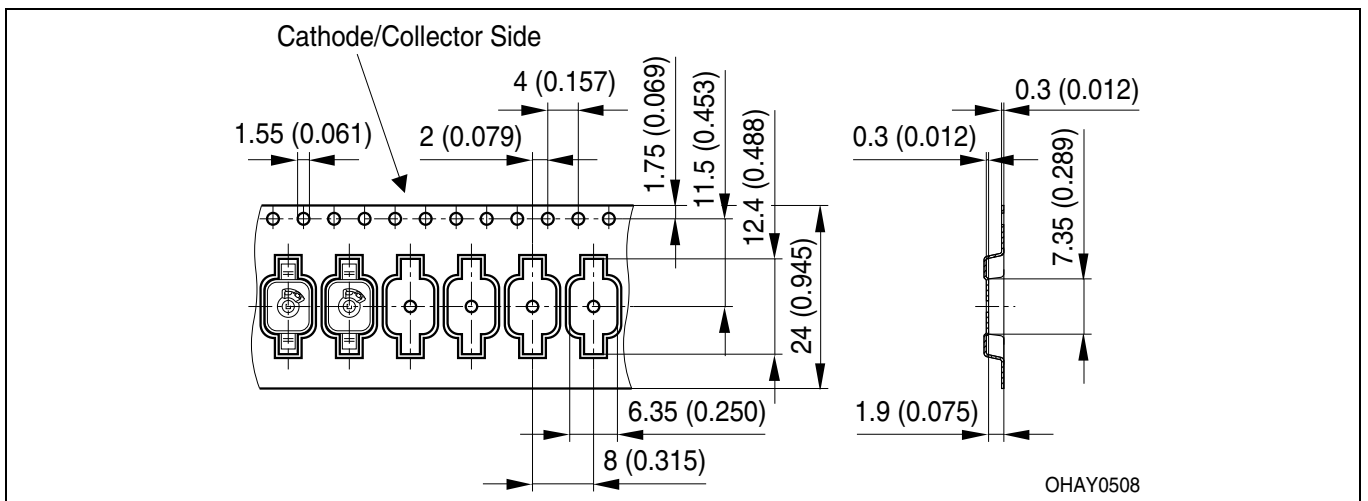
Korrosionsfestigkeit besser als EN 60068-2-60 (Methode 4):
 mit erweitertem Korrosionstest: 40°C / 90%rh / 15ppm H₂S / 336h
Corrosion robustness better than EN 60068-2-60 (method 4):
 with enhanced corrosion test: 40°C / 90%rh / 15ppm H₂S / 336h

Kathodenkennung:
Cathode mark:
Gewicht / Approx. weight:

Markierung
 mark
 0.2 g

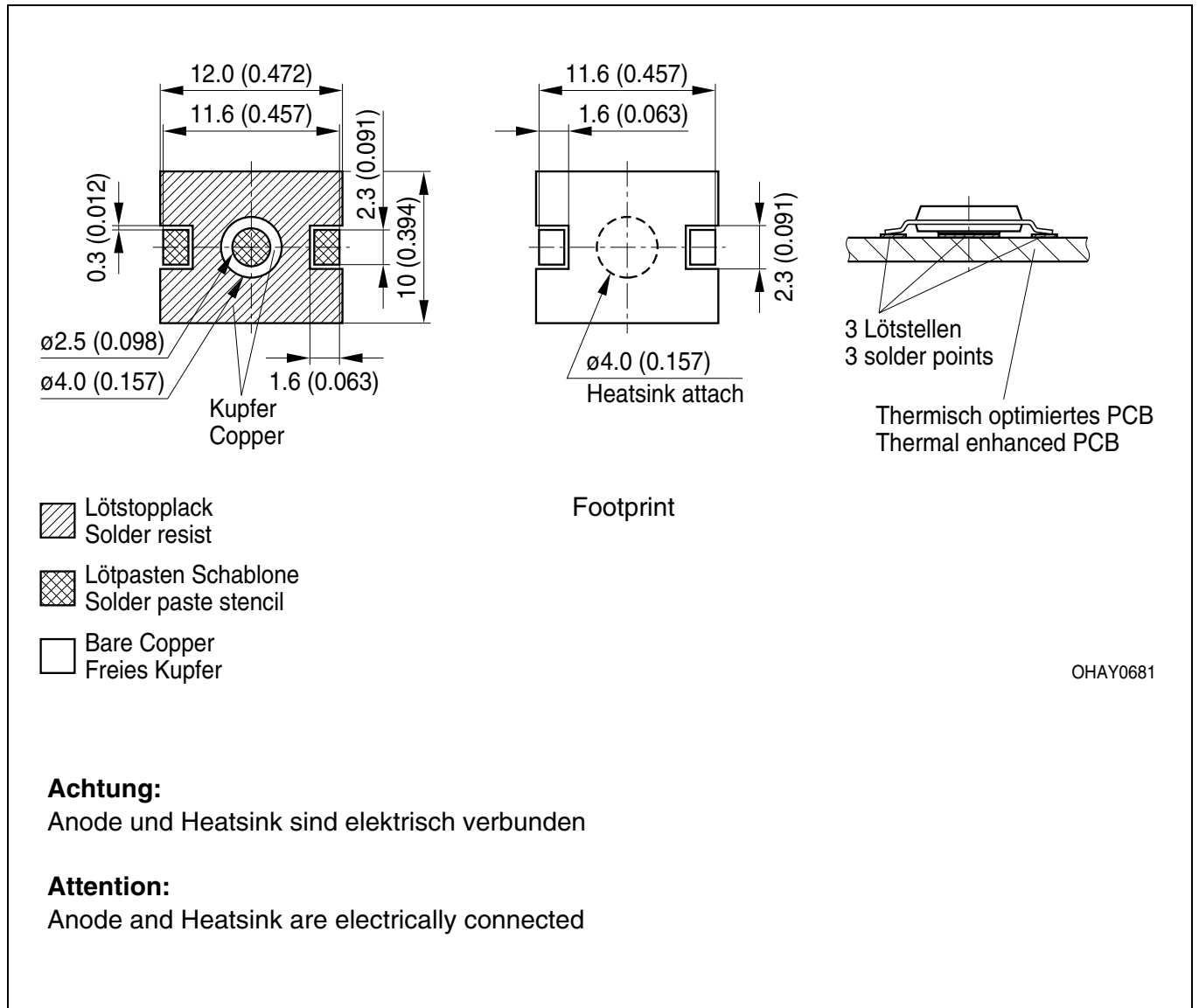
Gurtung / Polarität und Lage
Method of Taping / Polarity and Orientation

Verpackungseinheit 800/Rolle, ø180 mm
 Packing unit 800/reel, ø180 mm



¹⁾ Maße in mm (inch) / Dimensions in mm (inch)

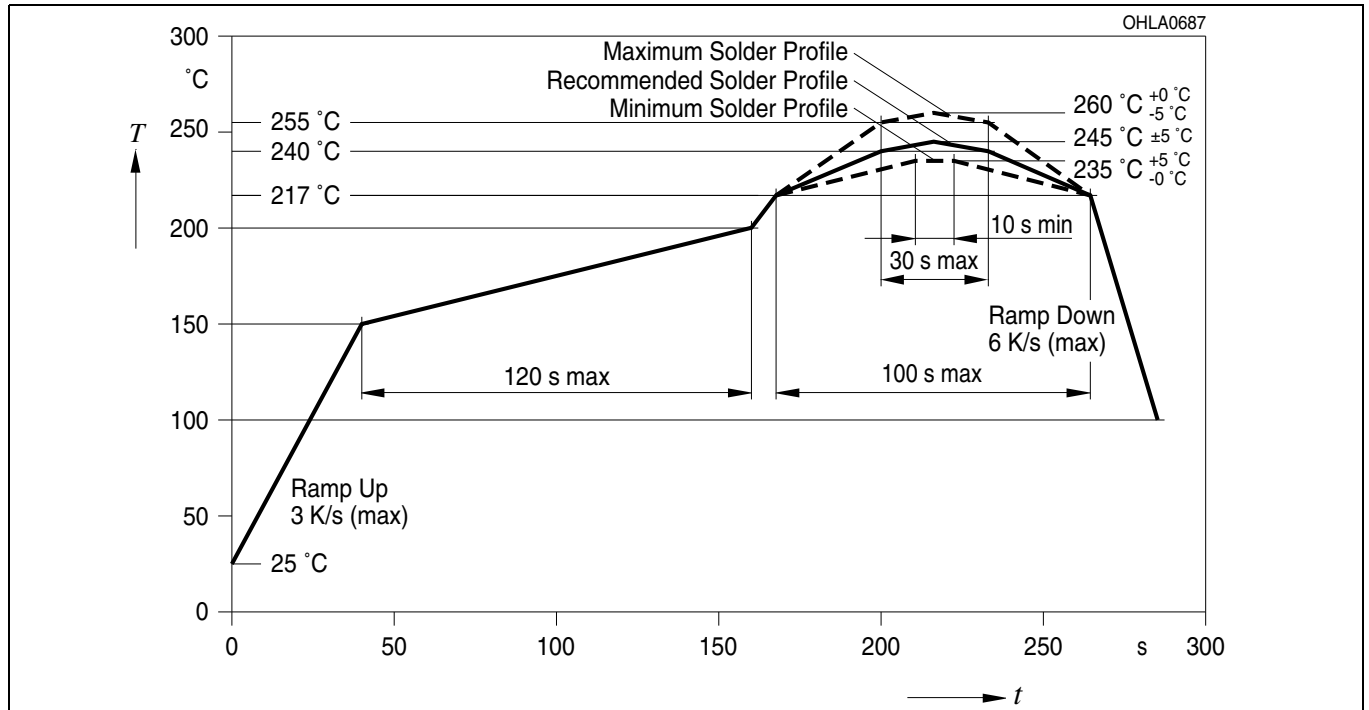
Empfohlenes Lötpaddesign
Recommended Solder Pad Design



Lötbedingungen Soldering Conditions

Reflow Lötprofil für bleifreies Löten
Reflow Soldering Profile for lead free soldering

Vorbehandlung nach JEDEC Level 2
Preconditioning acc. to JEDEC Level 2
(nach J-STD-020C)
(acc. to J-STD-020C)



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Components used in life-support devices or systems must be expressly authorized for such purpose! Critical components¹, may only be used in life-support devices or systems² with the express written approval of OSRAM OS.

¹ A critical component is a component used in a life-support device or system whose failure can reasonably be expected to cause the failure of that life-support device or system, or to affect its safety or effectiveness of that device or system.

² Life support devices or systems are intended (a) to be implanted in the human body, or (b) to support and/or maintain and sustain human life. If they fail, it is reasonable to assume that the health of the user may be endangered.

EU RoHS and China RoHS compliant product



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